Search Notes

Application/Control No.	ol No. Applicant(s)/Patent under Reexamination	
09/683,231	BENAYOUN ET AL.	
Examiner	Art Unit	
Afsar M. Qureshi	2667	

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SEARCHED					
Class	Subclass	Date	Examiner		
370	380	4/29/2005	AQ		
	381				
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	389				
	392				
	395.1				
	395.31				
375	316				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST/WEST/IEEE	4/29/2005	AQ	
IBM/ACM			
		<u>,                                      </u>	